

Notice of References Cited

Application/Control No.

10/083,496

Examiner

BINH Q. TRAN

Applicant(s)/Patent Under.

Reexamination
IIHOSHI ET AL.

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | - 185 | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|-------|--|-----------------|-----------------|----------------|
| | Α | US-S006401451B1 | 06-2002 | Yasui et al. | 60/277 |
| | В | US-US005804148A | 09-1998 | Kanesaka et al. | 422/174 |
| | С | US-US005761902 | 06-1998 | Usami et al. | 60/288 |
| | D | US-US005738832 | 04-1998 | Dogahara et al. | 422/171 |
| | Е | US-US006012284 | 06-2000 | Tanaka et al. | 60/297 |
| | F | US-US006158212 | 12-2000 | Tanaka | 60/277 |
| | G | US- | | | |
| | Н | US- | | | |
| | 1 | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| - | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | , | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| - | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | v | |
| | w | |
| | х | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.